



IECEx Quality Assessment Report Summary

INTERNATIONAL ELECTROTECHNICAL COMMISSION IEC Certification System for Explosive Atmospheres

for rules and details of the IECEx Scheme visit www.iecex.com

QAR Ref. No.:	NL/DEK/QAR13.0030/07	Page 1 of 1
QAR Free Ref. No.:	384031800	Status: Issued
Details of change:	re-assessment	Date of issue: 2025-07-29
	validity alignment with ATEX	Valid until: 2028-07-29
Location(s) audited:	Crystal Engineering Corporation 708 Fiero Lane Suite 9 San Luis Obispo California 93401 United States of America	Audit date: 2025-07-29
Issuing ExCB:	DEK - DEKRA Certification B.V.	
Manufacturer:	Crystal Engineering Corporation 708 Fiero Lane, Suite 9 San Luis Obispo, CA 93401 USA	
Location of Manufacturer:	United States of America	
Product information:	Digital Test Gauges and Pressure Recorders	
Type of protection:	Ex i	
Related QARs:		
NL/DEK/QAR13.0030/00	NL/DEK/QAR13.0030/01	NL/DEK/QAR13.0030/02
NL/DEK/QAR13.0030/03	NL/DEK/QAR13.0030/04	NL/DEK/QAR13.0030/05
NL/DEK/QAR13.0030/06		
Related Certificates (manual insertion)::		
FTZU 06ATEX 0010X		
FTZU 12ATEX 0048X		
FTZU 18ATEX 0043X		
FTZU 23ATEX 0015X		
SIRA 09ATEX 2008X		
ExVeritas 21UKEX 1098X		
ExVeritas 21UKEX 1099X		
ExVeritas 21UKEX 1100X		
CSAE 21UKEX 2456X		
Related Certificates (automatic linking)::		
Related Certificates for previous versions:		
IECEx FTZU 10.0018X issue: 2	IECEx FTZU 10.0018X issue: 3	IECEx FTZU 12.0009X issue: 2
IECEx FTZU 12.0009X issue: 3	IECEx FTZU 12.0009X issue: 4	IECEx FTZU 18.0012X issue: 0
IECEx FTZU 18.0012X issue: 1	IECEx FTZU 23.0017X issue: 0	IECEx SIR 09.0053X issue: 4
IECEx SIR 09.0053X issue: 5	IECEx SIR 09.0053X issue: 6	
Comments:	The listed ATEX Certificates are related to Notification No. DEKRA 13ATEXQ0151.	